

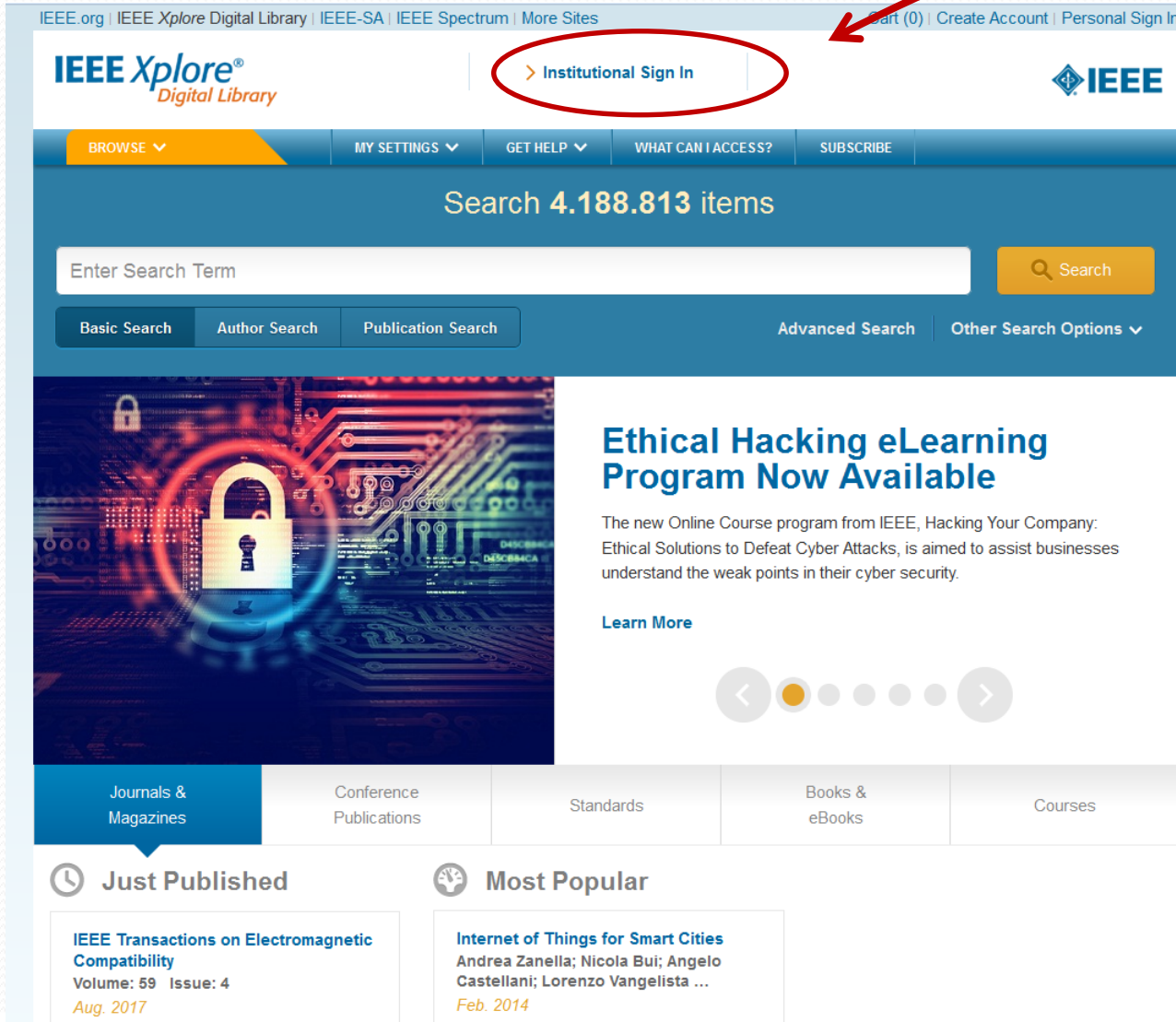
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Michael Jackson; Benjamin Freeman; Michael Smith; Michael Kemper
IEEE Journal of Quantum Electronics

Year: 2016, Volume: 52, Issue: 11

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Published in: IEEE Journal of Quantum Electronics (Volume: 52, Issue: 11, Nov. 2016)

Article Sequence Number: 1400104

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Date of Publication: 22 September 2016 ?

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